

# Component defect Analysis Report

FA Report No. : N018Y0528

Defect component: CISH-16-4405-01

Product Model : SRG (Sword GH)

Part Number : 73-16615-05

PCBA S/N : FD02205276J/FD022030LPG/ FD021500YNA

Failure : GET\_ROMMON failed at BST

Department : Cisco project TE

Reporter : Jizhao Yang

Date : 05/28/2018

# **Background Information**

## Reporter

Main Reporter: Jizhao Yang Employee ID: 576006

# **Product Failure Description**

Subject

SRG (Sword GH)

Phenomenon

**GET\_ROMMON** tests failed at BST

#### Information

Product Model: SRG Sword GH board 73-16615-05

# **Using Tools and Software:**

Oscilloscope---R&S RTM 2104 Multi-meter---Fluke 115C

## **Received and Observed Data**

(Issue date): 2018/05/28

(Where): SRG debug Area

## **Analysis and Cause Confirmation**

#### 1. Phenomenon:

These boards failed at BST station with failure code "GET\_ROMMON test failed"

### 2. Analysis:

Took one failed board (FDO2205276J) to debug bench for analysis:

1) Power on the board, the post code LEDs CR0\_P80 - CR7\_P80 keep solid green.

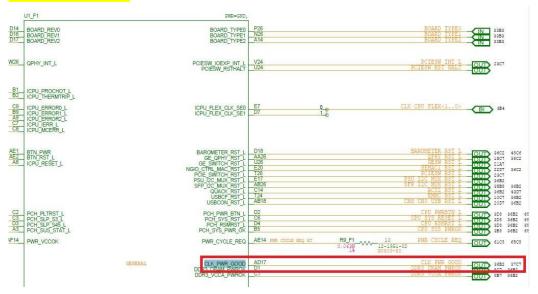
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2) According to debug experience, this failure may be related to U1\_CPU/U1\_F1 / U1\_CLK.We measured related signal, found U1\_F1 signal (CLK\_PWR\_GOOD) abnormal compared with known passed board.

#### Captured waveform shown as below:



#### CLK\_PWR\_GOOD signal related schematic shown as below:



- 3) Visual inspection (including 2D and 5D X-ray) for the whole PCBA especially for FPGA (U1\_F1), no process issue found
- 4) Re-balled the "suspected defective" FPGA, then mounted on a board which passed BST station, the board failed BST station with the same symptom "get ROMMON failed".

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5) After that, we measured the rest failed boards, all are same with FDO2205276J board. After replaced them with new U1\_F1 components, all symptoms disappeared and passed BST test.

Combined above, based on debug TOI(guideline) and experience, we suspected U1\_F1 failed.

#### 3. Primary conclusion and suggestion

1) The boards "GET\_ROMMON test fail" are caused by U1\_F1 defective. The failed component material information shown as below:

Raw Component	SN	DateC ode	Lot Code	Vendor	Vendor PN
CISH-16-4405-01	FDO22030LPG	1743	NAAAF54851A	ALTERA	EP4CGX75DF27C7N
CISH-16-4405-01	FDO2205276J	1749	NAAAF54982B	ALTERA	EP4CGX75DF27C7N
CISH-16-4405-01	FDO21500YNA	1743	NAAAF54681A	ALTERA	EP4CGX75DF27C7N

Material info:

CPN: CISH-16-4405-01

MPN: EP4CGX75DF27C7N

Where used: Sword GH

2) Send these "defective components" to supplier for further FA to find out the root cause

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